Operational Amplifiers CA6078A, CA6741

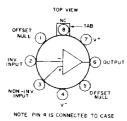
May 1990

Operational Amplifiers

CA6078AT - Micropower Type CA6741T - General-Purpose Type

For Applications where Low Noise (Burst + 1/f) is a Prime Requirement

Virtually free from "popcorn" (burst) noise: device rejected if any noise burst exceeds 20 mV (peak), referred to input over a 30-second time period.



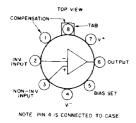
CA6741T

Features:

- Internal phase compensation
- input bias current: 500 nA max.
- Input offset current: 200 nA max.
- Open loop voltage gain: 50,000 (94 dB) min.
- Input offset voltage: 5 mV max.

Applications:

- Low noise AC amplifier
- Narrow band or bandpass filter
- Integrator or differentiator
- DC amplifier
- Summing amplifier



CA6078AT

Features:

- Open loop voltage gain: 40,000 (92 dB) min.
- Input offset voltage: 3.5 mV max.
 Operates with low total supply
- voltage: 1.5 V min. (±0.75 V)
- Low quiescent operating current: adjustable for application optimization
- Input bias current: adjustable to below 1 nA

Applications:

- Portable electronics
- Medical electronics
- DC amplifier
- Narrow band or bandpass filter
- Integrator or differentiator
- Instrumentation
- Telemetry
- Summing amplifier

CA6078AT and CA6741T* are low-noise linear IC operational amplifiers that are virtually free of "popcorn" (burst) noise.

These low noise versions of the CA3078AT and CA3471T are a result of improved processing developments and rigid burst noise inspection criteria. A highly selective test circuit (See Figure 2) assures that each type meets the rigid low noise standards in the data section. This low burst noise property also assures excellent performance throughout the 1/f noise spectrum.

In addition the CA6078AT and CA6741T offer the same features incorporated in the CA3078AT and CA3741T respectively, including output short circuit protection, latch free operation, wide common-mode and differential-mode signal ranges, and low offset nulling capability.

For detailed data, characteristics curves, schematic diagram, dimensional outline, and test circuits, refer to the Operational Amplifier Data Bulletins File No. 531 and 535. In addition, for details of considerations in burst-noise measurements, refer to Application Note, ICAN-6732, "Measurement of Burst ("Popcorn") Noise in Linear IC's".

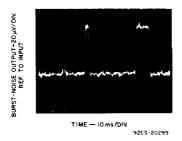
The CA6078AT and CA6741T utilize the hermetically sealed 8-lead TO-5 type package. The CA6078AT and the CA6741T can also be supplied on request with dual-in-line formed leads. These types are identified as the CA6078AS and CA6741S. This formed-lead configuration conforms to that of the 8-lead dual-in-line (Mini-Dip) package. For terminal arrangements, see page 4.

*Formerly Dev. No. TA5807X and TA6029 respectively.

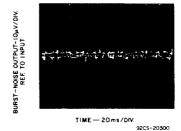
MAXIMUM RATINGS, Absolute-Maximum Values at TA = 25°C

	CA6741T	CA6078AT
DC Supply Voltage (between V ⁺ and V ⁻ terminals)	44 V	36 V
Differential-Mode Input Voltage	±30 V	±6 V
Common-Mode DC Input Voltage	±15 V	V ⁺ to V ⁻
Device Dissipation:		
Up to 75°C (CA6741T), Up to 125° (CA6078AT)	500 mW	250 mW
Above 75°C	Derate linearly 5 mW/°C	_
Temperature Range:		
Operating	-55 to +125 °C	−55 to +125 °C
Storage	-65 to +150 °C	-65 to +150 °C
Output Short-Circuit Duration	No limitation	No limitation
Lead Temperature (During soldering):		
At distance $1/16 \pm 1/32$ inch $(1.59 \pm 0.79 \text{ mm})$		
from case for 10 seconds max.	300 oC	300 oC

[▲]If Supply Voltage is less than ±15 volts, the Absolute Maximum Input Voltage is equal to the Supply Voltage.



a. Typ. device with high-burst-noise characteristic.



b. Typ. device controlled for burst noise.

Fig.1-Typ. waveforms of type with high burst noise and type controlled for burst noise.

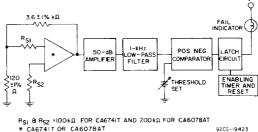


Fig.2-Block diagram of burst-noise "popcorn" test equipment.

[•]Short circuit may be applied to ground or to either supply.

CA6078A, CA6741

ELECTRICAL CHARACTERISTICS - CA6078AT, For Equipment Design.

CHARACTERISTICS SYMBOLS		TEST CONDITIONS	LIMITS			
	Supply Volts: $V^+ = 6$, $V^- = -6$ $T_A = 25^{\circ}C$, $I_Q = 20 \mu A$	MIN.	TYP.	MAX.	UNITS	
Noise Characteristic			<u> </u>			
"Popcorn"		Bandwidth = 1 kHz	Device is rejected if the total noise voltage (burst + $1/f$), referred to input, exceeds $20 \mu\text{V}$ peak, during a 30-sec. test period			
(Burst) Noise		$R_{SI} = R_{S2} = 200 \text{ k}\Omega$				
Principal Characteristics (For detailed E	lectrical Char	acteristics refer to CA3078AT Dat	a Bulletin,	File No. 53	35.)	
Input Offset Voltage	V ₁₀	$R_S \le 10 \text{ k}\Omega$	-	0.7	3.5	mV
Input Offset Current	110		****	0.5	2.5	nA
Input Bias Current	118		-	7	12	nA
Open-Loop						
Differential	AOL	$R_L \ge 10 \text{ k}\Omega$	40,000	100,000	_	
Voltage Gain		V _O = ±4V	92	100	_	dB
Common-Mode Input Voltage Range	VICR	V+ = V- = 15 V	±14	_	_	V
Common-Mode Rejection Ratio	CMRR	$R_S \le 10 \text{ k}\Omega$	80	115	_	dΒ
Output Voltage Swing VO(P-P)	R _L \geq 10 Ω	±13.7	±14.1	-		
	VO(P-P)	$R_{L} \ge 2 k\Omega$	_	±14		
Supply Current	IQ		-	20	25	μΑ

ELECTRICAL CHARACTERISTICS - CA6741T, For Equipment Design.

CHARACTERISTICS SYMBOLS		TEST CONDITIONS	LIMITS			
	Supply Volts; $V^+ = 15$, $V^- = -15$ $T_A = 25^{\circ}C$	MIN.	TYP.	MAX.	UNITS	
Noise Characteristic				·		
"Popcorn"		Bandwidth = 1 kHz	Device is rejected if the total noise voltage (burst + $1/f$), referred to input, exceeds $20 \mu\text{V}$ peak, during a 30-sec. test period			
(Burst) Noise		$R_{S1} = R_{S2} = 100 \text{ k}\Omega$				
Principal Characteristics (For detailed I	Electrical Char	acteristics refer to CA3741T Data	Bulletin,	File No. 53	1.)	
Input Offset Voltage	۷ı٥	$R_S \le 10 \text{ k}\Omega$		1	5	mV
Input Offset Current	40		_	20	200	nΑ
Input Bias Current	Iв		-	80	500	nΑ
Open-Loop						
Differential	AOL	$R_L \ge 2 k\Omega$	50,000	200,000	_	
Voltage Gain		V _O = ±10 V	94	106	_	dB
Common-Mode Input Voltage Range	VICR		±12	±13	_	V
Common-Mode Rejection Ratio	CMRR	$R_S \le 10 \text{ k } \Omega$	70	90		dB
Output Voltage Swing VO(P-P)	R _L ≥ 10 k Ω	±12	±14	-		
	VO(P-P)	$R_L \ge 2 k \Omega$	±10	±13		- Y
Supply Current	IQ.		-	1.7	2.8	mA

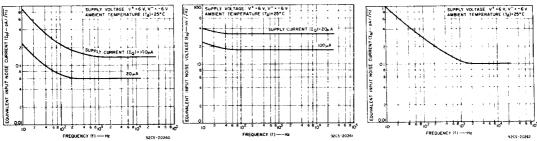


Fig.3-IN vs. Frequency for CA6078AT.

Fig.4-E_N vs. Frequency for CA6078AT.

Fig.5-IN vs. Frequency for CA6741T.

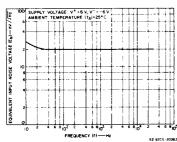


Fig.6-EN vs. Frequency for CA6741T.

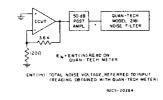


Fig.7-Test block diagram for EN.

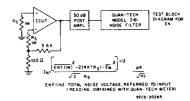


Fig.8-Test block diagram for IN.